High resolution X-ray imaging system

Obtain high-resolution images with submicron resolution



Easily and flexibly, build an X-ray imaging system tailored to your needs

A high-resolution X-ray imaging system combines an imaging unit that visualizes the incident X-ray beam with a phosphor and a camera.

By simply selecting the main body of the X-ray imaging system (M11427), the phosphor screen*, and the optical system*, you can easily acquire X-ray images. You can freely choose a camera from the lineup and build a system by combining the optical system and camera according to your application.

Additionally, the optical design considers the durability and maintainability of the device, making it suitable for imaging using strong X-rays used in synchrotron radiation facilities.

APPLICATIONS

- Synchrotron imaging
- X-ray beam alignment
- X-ray CT
- X-ray microscope
- X-ray topography
- XAFS

High-resolution images

A microscopic type that specializes in spatial resolution and is able to identify 1 µm line and space or less.





* The spatial resolution and effective field of view in the left diagram are examples of actual values measured with visible light without a phosphor. Please refer to it as reference data. Please contact Hamamatsu for detailed measurement conditions.

Correlation diagram of spatial resolution and effective field of view (reference data)

Reduce camera damage with X-ray resistant design

By adopting an L-shaped optical design to prevent X-ray beams from directly entering the camera, we reduced the damage to the camera caused by X-rays.



Easily replace the camera as needed

For the microscopic type, a camera is attached with a C-mount or F-mount (option). You can choose a suitable camera from our lineup of scientific cameras according to your requirements for readout speed and readout noise.

Camera	ORCA-Quest qCMOS [®] came	A-Quest 2 DS [®] camera		;	ORCA-Fusion BT Digital CMOS camera		ORCA-Flash4.0 V3 Digital CMOS camera	
Product number	C15550-22U	Р	C16240-20UP		C15440-20UP		C13440-20CU	
			0		O		0	
Effective number of pixels (H×V)	4096 × 2304	ļ	4432 × 2368		2304 × 2304		2048 × 2048	
Pixel size [μm (H) × μm (V)]	4.6 × 4.6		4.6 × 4.6		6.5 × 6.5		6.5 × 6.5	
Effective area [μm (H) × μm (V)]	18.841 × 10.598		20.387 × 10.892		14.976 × 14.976		13.312 × 13.312	
Full well capacity (electrons, typ.) *1	7000	20 000			15 000		30 000	
	Standard scan	120	Full resolution	115	Fast scan	89.1	Standard scan	100
Readout speed (frames/s, typ.) *1	Ultra quiet scan	25.4	Vertical 4 line	19 500	Standard scan	23.2	Slow scan	30
					Ultra quiet scan 5.42		_	
	Standard scan	0.43	Full resolution	1.0	Fast scan	1.6	Standard scan	1.6
Readout noise (electrons, rms, tvp.) *1	Ultra quiet scan	0.30	_		Standard scan	1.0	Slow scan	1.4
	-		_		Ultra quiet scan 0.7		-	

*1 It varies depending on the conditions. Please contact Hamamatsu for details.

Focus adjustment with a controller

Focus adjustment of the images is done using a dedicated controller. The cable connecting the main unit and the controller is 15 meters long, making it possible to perform adjustments from a location away from the main unit.



Parts can be replaced due to the attachment structure

The phosphor screen and objective lens are mounted by detaching the holder. They can be easily replaced without using tools, allowing you to freely combine them according to the sample or application.



screen



Easily replace without using tools

Phosphor screens Options

Three types of phosphor screens are available: direct bonding type, glue bonding type, and free standing type. Among these, the direct bonding type has high X-ray durability and enables stable imaging even at high doses.

Bonding method	Product number	Phosphor material	Peak emission wavelength	Decay time	Phosphor thickness	Phosphor diameter	Phosphor effective diameter	Base material of phosphor	Space ring
	A15150-LU010DB	LuAG *1 (Lu ₂ Al ₅ O ₁₂ ; Ce+)	535 nm	70 ns	10 µm				
	A15150-LU050DB				50 µm				
Direct bonding	A15150-LU100DB	(3 3 12 -)			100 µm				
	A15150-GA010DB	04.00.01	520 nm	92 ns	10 µm				
See page 5	A15150-GA050DB	(Gd ₂ Al ₂ Ga ₂ O ₁₂ ; Ce+)			50 µm			Amorphous carbon	
	A15150-GA100DB	(003, 12003012, 001)			100 µm	15 mm	10 mm		
Glue bonding	A15150-LU010GB	LuAG *1 (Lu ₃ Al ₅ O ₁₂ : Ce+)	535 nm	70 ns	10 µm		Thickness 1 mm	Black plastic	
	A15150-LU050GB				50 µm				Outer diameter 20 mm Inner diameter 16 mm Thickness 2 mm
	A15150-LU100GB				100 µm				
	A15150-GA010GB	GAGG *1 (Gd ₃ Al ₂ Ga ₃ O ₁₂ : Ce+)	520 nm	92 ns	10 µm				
	A15150-GA050GB				50 µm				
	A15150-GA100GB				100 µm				
Free standing*2	A15141-LU	LuAG *1 (Lu ₃ Al ₅ O ₁₂ : Ce+)	535 nm	70 ns	- 1000 µm	20 mm	16 mm	-	
	A15141-GA	GAGG *1 (Gd ₃ Al ₂ Ga ₃ O ₁₂ : Ce+)	520 nm	92 ns					

*1 For LuAG and GAGG, a streak and white spots may occur. These are due to the characteristics of the single-crystal phosphor and are not a defect. *2 It is necessary to block the ambient visible light in the operating environment.

Optical components Options

Product number	Product name	Note
A15614-01	Objective lens 10× for AA51	Additional lens for M11427-58S or -58B
A15614-02	Objective lens 20× for AA51	Additional lens for M11427-57S or -57B
A15614-03	F-mount camera adapter for AA51	For F-mount camera

Light path



High-durability single-crystal phosphor screen revolutionizes conventional imaging Direct bonding

The direct bonding type phosphor screen that can be selected as an option is a single-crystal phosphor screen with extremely high X-ray durability.

It suppresses the destruction of a phosphor screen by X-rays and realizes stable imaging and measurement for a long period of time.

Even with prolonged exposure to white X-rays, which usually causes destruction in conventional phosphor, this product remains undamaged.

Measurement conditions

Beam line	SPring-8 BL28B2
X-ray energy	White
Attenuator	Air (9 m), Aluminum (0.034 mm) Be window (1 mm thick on the beam line side + 0.5 mm thick on the detector side)
Beam size	3 mm × 3 mm
Detector	Glue bonding type: AA40 (f = 50 mm) + ORCA-Flash2.8 (f = 35 mm) Direct bonding type: AA40 (f = 50 mm) + ORCA-Flash4.0 (f = 50 mm)
Pixel resolution	Glue bonding type: 5.1 μm / pixel, Direct bonding type: 6.5 μm / pixel
Phosphor screen	LuAG (Thickness: Glue bonding type about 20 $\mu\text{m},$ Direct bonding type about 20 $\mu\text{m})$

Data courtesy of:

JASRI (Japan Synchrotron Radiation Research Institute) Industrial application Division Dr. Kentaro Kaiiwara

* The measurement condition and data are at the time of evaluation and may not apply to all cases. Please consider as a reference case.

X-ray durability evaluation Synchrotron radiation white X-ray **Conventional phosphor** (Glue bonding type) Even with prolonged exposure to

App Ia

Approx. 12 min later (700 s)

Destruction taking place

High-durability single-crystal phosphor screen (Direct bonding type)







X-ray durability evaluation 2 Flux density 4.7 ×10¹³ photons/s/mm²

Conventional phosphor (Glue bonding type)



6 min. later



Destruction taking place

High-durability single-crystal phosphor screen (Direct bonding type)





Even with prolonged exposure to X-rays with high flux density, which usually causes destruction in conventional phosphor, this product remains undamaged.

Measurement conditions

Beam line	SPring-8 BL47XU
X-ray energy	8 keV
Attenuator	None
Flux density	4.7×10 ¹³ photons/s/mm ²
Beam size	350 μm × 350 μm
Detector	AA50 (objective lens10×/NA 0.3) + C13949-50U
Pixel resolution	0.21 µm/pixel
Phosphor screen	LuAG (Thickness: Glue bonding type 22.3 µm, Direct bonding type 21.4 µm)

Data courtesy of:

JASRI (Japan Synchrotron Radiation Research Institute)

Dr. Kentaro Uesugi

* The measurement condition and data are at the time of evaluation and may not apply to all cases. Please consider as a reference case.



High-durability single-crystal phosphor screen

SiC defect observation



Test conditions

Method	X-ray topography			
Camera	ORCA-Flash4.0 V3			
Sample	SiC single crystal substrate			
Sample	(dislocations in the crystal)			
X-ray energy	9 keV			
Pixel size	0.65 µm			
Magnification	×10			
Exposure time	10 s			
Number of pixels	1970 pixels × 1970 pixels			
in the target image	(1.28 mm × 1.28 mm)			
Phosphor screens	LuAG 10 µm			

Data courtesy of: Innovation Center for Semiconductor and Digital Future, Mie University Yongzhao Yao, Ph.D

Internal observation of wood



Cross-sectional view after 3D image reconstruction

Test conditions

Method	X-ray CT		
Camera	ORCA-Fusion BT		
Sample	Toothpick		
Exposure time	100 ms/projection		
Number of projections	1800		
X-ray energy	15 keV		
Pixel size	0.65 µm		

Data courtesy of: Photon Science Innovation Center

Specifications

In addition, the cable connection position can be selected from two patterns, side panel and back panel, depending on the space for installation.

- M11427-57B, -58B: Back panel
- M11427-57S, -58S: Side panel

High resolution X-ray imaging system AA51

Product number	M11427-57B, -57S	M11427-58B, -58S	
X-ray energy	6 keV or higher		
Phosphor effective diameter			
Phosphor material	Refer to specifications		
Peak emission wavelength			
Decay time	lor phosphor screens		
Thickness of phosphor (typ.)	(wolad)		
Base material of phosphor	1		
Spatial resolution *1	1 µm or less 800 nm or less		
1st lens	10× (NA 0.45) 20× (NA 0.75)		
2nd lens	200 mm		

*1 Reference value with ORCA-Flash4.0 V3. It varies depending on the system configuration.

System configuration examples

Frame grabber board and their cables are available with options depending on the camera used. For details, please contact your Hamamatsu representative or distributor.



Dimensional outlines (unit: mm)

• High resolution X-ray imaging system AA51 M11427-57B, -57S, -58B, -58S (Approx. 7.5 kg)



orca-Quest2

The dawn of a new era for scientific measurement cameras

The ORCA-Quest 2 is a camera that leverages the design technology cultivated at Hamamatsu Photonics to achieve an extremely low noise performance of 0.30 electrons rms and high-speed readout. It is ideal for quantitative imaging under extremely low light conditions.

URL https://www.hamamatsu.com/all/en/product/cameras/qcmos-cameras/C15550-22UP.html

X-ray CMOS cameras

High-resolution and high-sensitivity X-ray sCMOS camera

The camera is suitable for micro object by achieving 33 lp/mm high resolution image. Also the product is compact that is suitable as embedded devices for Micro CT/Nano CT system.

URI https://www.hamamatsu.com/all/en/product/cameras/x-ray-cmos-cameras/C12849-111U.html

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HAMAMATSU PHOTONICS K.K. www.hamamatsu.com

Systems Division

812 Joko-cho, Chuo-ku, Hamamatsu City, 431-3196, Japan, Telephone: (81)53-431-0124, Fax: (81)53-433-8031, E-mail: export@sys.hpk.co.jp

U.S.A.: HAMAMATSU CORPORATION: 360 Foothill Road, Bridgewater, NJ 08807, U.S.A., Telephone: (1)908-231-0960, Fax: (1)908-231-1218

U.S.A: HAMAMATSU CORPORATION: 360 Foothill Road, Bridgewater, NJ 08807, U.S.A., Telephone: (1)908-231-0960, Fax: (1)908-231-1218 Germany: HAMAMATSU PHOTONICS DEUTSCHLAND GMBH: Arzbergerstr. 10, 82211 Herrsching am Ammersee, Germany, Telephone: (49)8152-375-0, Fax: (49)8152-265-8 E-mail: info@hamamatsu.de France: HAMAMATSU PHOTONICS SRANCE S.A.R.L: 19 Rue du Saule Trapu, Parc du Moulin de Massy, 91882 Massy Cedex, France, Telephone: (33)1 69 53 71 00, Fax: (33)1 69 53 71 10 E-mail: info@hamamatsu.de North Europe: HAMAMATSU PHOTONICS UK LIMITED: 2 Howard Court, 10 Tewin Road, Welwyn Garden City, Hertfordshire, AL7 1BW, UK, Telephone: (44)1707-294888, Fax: (44)1707-325777 E-mail: info@hamamatsu.co.uk North Europe: HAMAMATSU PHOTONICS NCNDED AB: Torshamnsgatan 35 16440 Kista, Sweden, Telephone: (46)8-509 031 00, Fax: (46)8-509 031 01 E-mail: info@hamamatsu.it Italy: HAMAMATSU PHOTONICS SCHILA S.R.L: Strada della Moin, 1 int 6, 2004 Arese (Milano), Italy, Telephone: (49)3 56 17 31, Fax: (39)20-39 56 17 31. E-mail: info@hamamatsu.it China: HAMAMATSU PHOTONICS (CHINA) CO., LTD.: 1201 Tower B, Jiaming Center, 27 Dongsanhuan Beilu, Chaoyang District, 100020 Beijing, P.R. China, Telephone: (86)10-6586-6006, Fax: (86)10-6586-2066 E-mail: info@hamamatsu.com.tw



